

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/698,155	<b>Applicant(s)/Patent under Reexamination</b> KUNE ET AL.
	<b>Examiner</b> Hai C. Pham	<b>Art Unit</b> 2861

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
347	19	12/24/2005	HP
PGPub Text Search		12/24/2005	HP